

**APPLICATION**

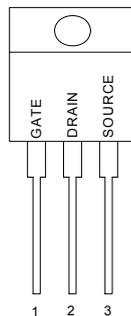
- ◆ DC motor control
- ◆ UPS
- ◆ Class D Amplifier

$V_{DSS}$	$R_{DS(ON)}$ Typ.	$I_D$
60V	15.8m $\Omega$	60A

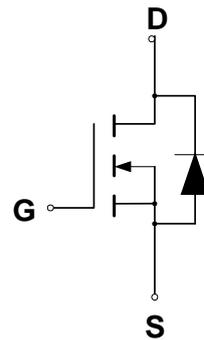
**PIN CONFIGURATION**

 TO-220  
Front View

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**FEATURES**

- ◆ Low ON Resistance
- ◆ Low Gate Charge
- ◆ Peak Current vs Pulse Width Curve
- ◆ Inductive Switching Curves

**SYMBOL**


N-Channel MOSFET

**ABSOLUTE MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain to Source Voltage (Note 1)	$V_{DSS}$	60	V
Drain to Current — Continuous $T_c = 25^\circ\text{C}$ , $V_{GS}@10\text{V}$	$I_D$	60	A
	$I_D$	43	
	$I_{DM}$	241	
— Continuous $T_c = 100^\circ\text{C}$ , $V_{GS}@10\text{V}$			
— Pulsed $T_c = 25^\circ\text{C}$ , $V_{GS}@10\text{V}$ (Note 2)			
Gate-to-Source Voltage — Continue	$V_{GS}$	$\pm 20$	V
Total Power Dissipation	$P_D$	150	W
		Derating Factor above $25^\circ\text{C}$	1.0
Peak Diode Recovery $dv/dt$ (Note 3)	$dv/dt$	4.5	V/ns
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 175	$^\circ\text{C}$
Single Pulse Avalanche Energy $L=144\mu\text{H}, I_D=40$ Amps	$E_{AS}$	500	mJ
Maximum Lead Temperature for Soldering Purposes	$T_L$	300	$^\circ\text{C}$
Maximum Package Body for 10 seconds	$T_{PKG}$	260	$^\circ\text{C}$
Pulsed Avalanche Rating	$I_{AS}$	60	A

**THERMAL RESISTANCE**

Symbol	Parameter	Min	Typ	Max	Units	Test Conditions
$R_{\theta JC}$	Junction-to-case			1.0	$^\circ\text{C}/\text{W}$	Water cooled heatsink, $P_D$ adjusted for a peak junction temperature of $+175^\circ\text{C}$
$R_{\theta JA}$	Junction-to-ambient			62	$^\circ\text{C}/\text{W}$	1 cubic foot chamber, free air

**ORDERING INFORMATION**

Part Number	Package
CMT60N06G	TO-220

**ELECTRICAL CHARACTERISTICS**

 Unless otherwise specified,  $T_J = 25^\circ\text{C}$ .

Characteristic		Symbol	CMT60N06G			Units
			Min	Typ	Max	
<b>OFF Characteristics</b>						
Drain-to-Source Breakdown Voltage ( $V_{GS} = 0\text{ V}$ , $I_D = 250\ \mu\text{A}$ )		$V_{DSS}$	60			V
Breakdown Voltage Temperature Coefficient (Reference to $25^\circ\text{C}$ , $I_D = 250\ \mu\text{A}$ )		$\Delta V_{DSS}/\Delta T_J$		0.069		mV/ $^\circ\text{C}$
Drain-to-Source Leakage Current ( $V_{DS} = 60\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 25^\circ\text{C}$ ) ( $V_{DS} = 48\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 150^\circ\text{C}$ )		$I_{DSS}$			25 250	$\mu\text{A}$
Gate-to-Source Forward Leakage ( $V_{GS} = 20\text{ V}$ )		$I_{GSS}$			100	nA
Gate-to-Source Reverse Leakage ( $V_{GS} = -20\text{ V}$ )		$I_{GSS}$			-100	nA
<b>ON Characteristics</b>						
Gate Threshold Voltage ( $V_{DS} = V_{GS}$ , $I_D = 250\ \mu\text{A}$ )		$V_{GS(th)}$	1.0	2.0	3.0	V
Static Drain-to-Source On-Resistance (Note 4) ( $V_{GS} = 10\text{ V}$ , $I_D = 60\text{ A}$ )		$R_{DS(on)}$		15.8	18	m $\Omega$
Forward Transconductance ( $V_{DS} = 15\text{ V}$ , $I_D = 60\text{ A}$ ) (Note 4)		$g_{FS}$		36		S
<b>Dynamic Characteristics</b>						
Input Capacitance	$(V_{DS} = 25\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1.0\text{ MHz}$ )	$C_{iss}$		1430		pF
Output Capacitance		$C_{oss}$		420		pF
Reverse Transfer Capacitance		$C_{rss}$		88		pF
Total Gate Charge ( $V_{GS} = 10\text{ V}$ )	$(V_{DS} = 30\text{ V}$ , $I_D = 60\text{ A}$ , $V_{GS} = 10\text{ V}$ ) (Note 5)	$Q_g$		37.7		nC
Gate-to-Source Charge		$Q_{gs}$		8.4		nC
Gate-to-Drain ("Miller") Charge		$Q_{gd}$		9.8		nC
<b>Resistive Switching Characteristics</b>						
Turn-On Delay Time	$(V_{DD} = 30\text{ V}$ , $I_D = 60\text{ A}$ , $V_{GS} = 10\text{ V}$ , $R_G = 9.1\ \Omega$ ) (Note 5)	$t_{d(on)}$		12.1		ns
Rise Time		$t_{rise}$		64		ns
Turn-Off Delay Time		$t_{d(off)}$		69		ns
Fall Time		$t_{fall}$		39		ns
<b>Source-Drain Diode Characteristics</b>						
Continuous Source Current (Body Diode)	Integral pn-diode in MOSFET	$I_S$			60	A
Pulse Source Current (Body Diode)		$I_{SM}$			241	A
Diode Forward On-Voltage ( $I_S = 60\text{ A}$ , $V_{GS} = 0\text{ V}$ )		$V_{SD}$			1.5	V
Reverse Recovery Time	$(I_F = 60\text{ A}$ , $V_{GS} = 0\text{ V}$ , $d_i/d_t = 100\text{ A}/\mu\text{s}$ )	$t_{rr}$		55		ns
Reverse Recovery Charge		$Q_{rr}$		110		nC

 Note 1:  $T_J = +25^\circ\text{C}$  to  $+175^\circ\text{C}$ 

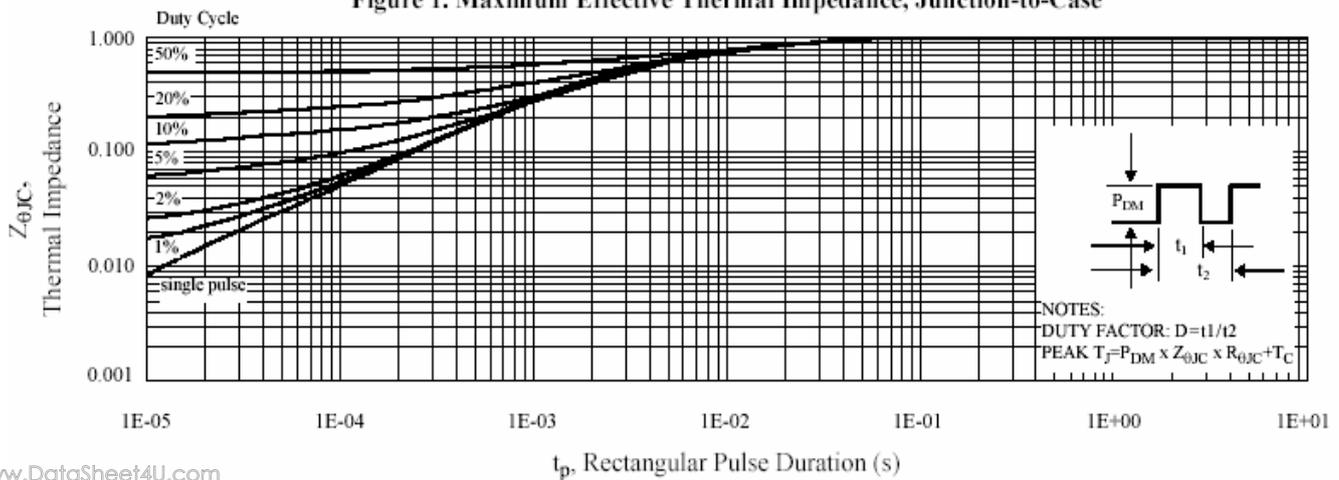
Note 2: Repetitive rating; pulse width limited by maximum junction temperature.

 Note 3:  $I_{SD} = 60\text{ A}$ ,  $d_i/d_t \leq 100\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ ,  $T_J = +175^\circ\text{C}$ 

 Note 4: Pulse width  $\leq 250\ \mu\text{s}$ ; duty cycle  $\leq 2\%$ 

Note 5: Essentially independent of operating temperature.

Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case



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Figure 2. Maximum Power Dissipation vs Case Temperature

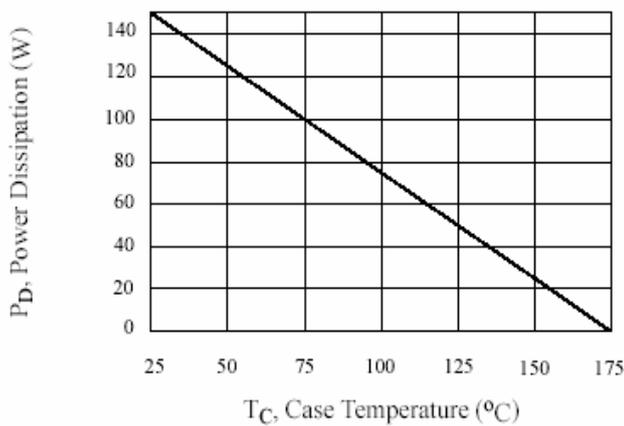


Figure 3. Maximum Continuous Drain Current vs Case Temperature

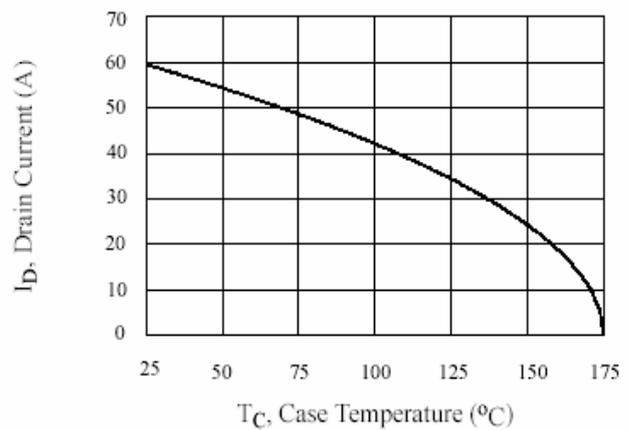


Figure 4. Typical Output Characteristics

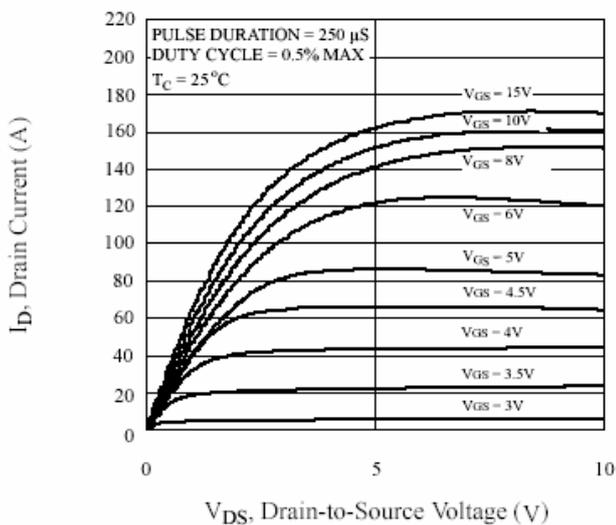
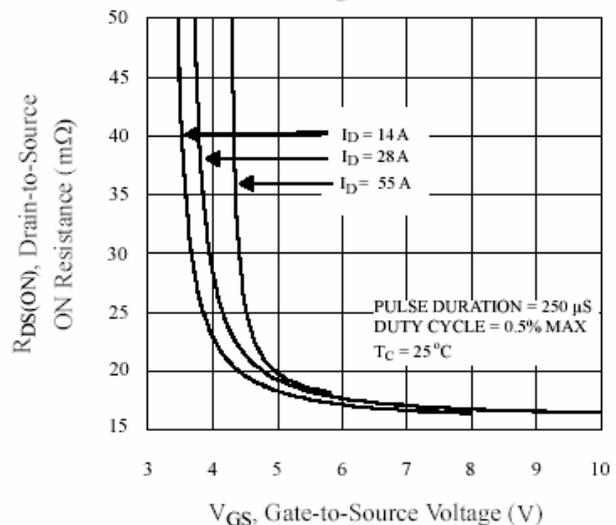
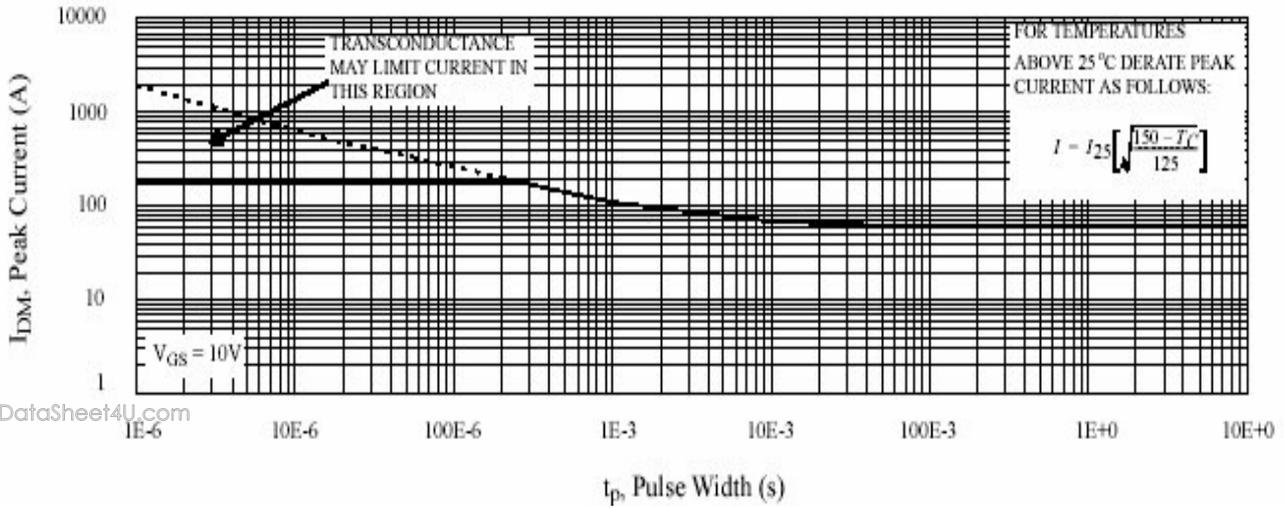
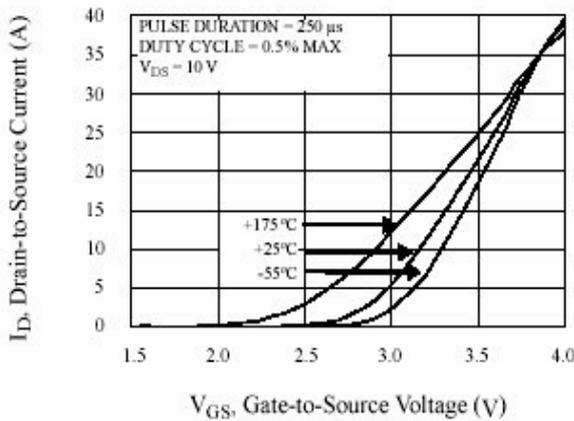
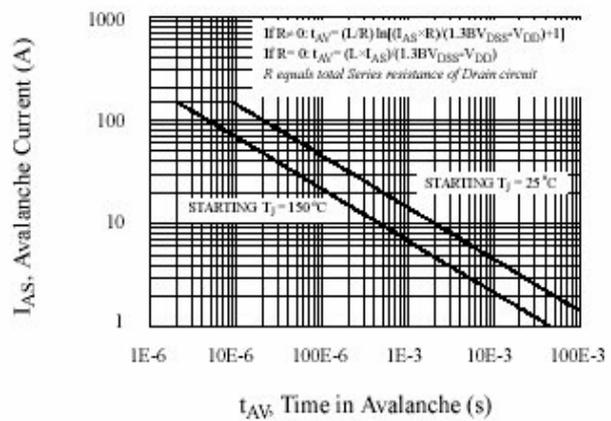
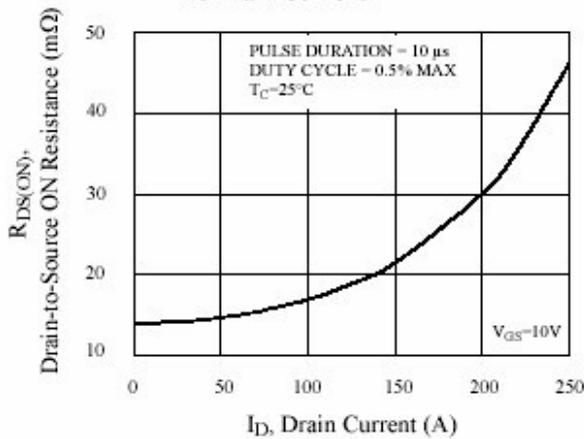
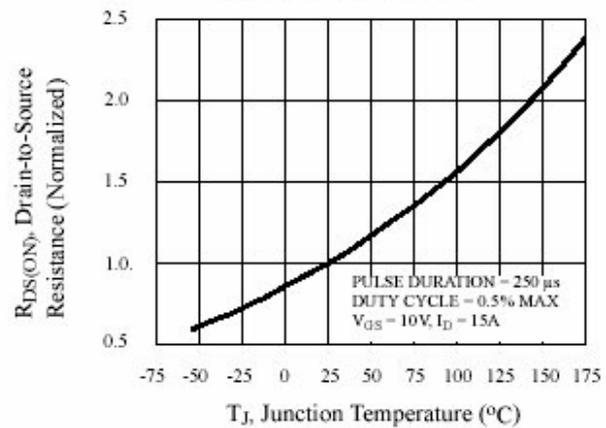
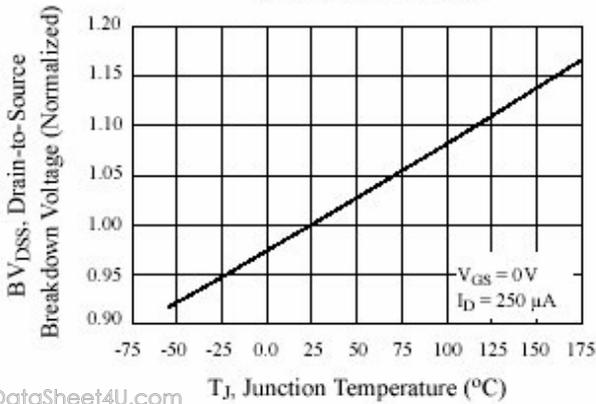


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current

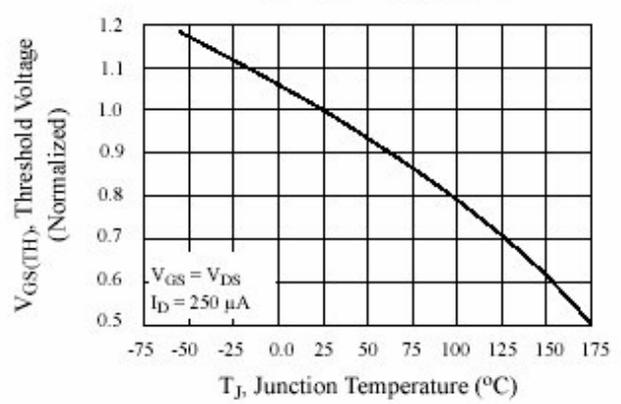


**Figure 6. Maximum Peak Current Capability**

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**Figure 7. Typical Transfer Characteristics**

**Figure 8. Unclamped Inductive Switching Capability**

**Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current**

**Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature**


**Figure 11. Typical Breakdown Voltage vs Junction Temperature**

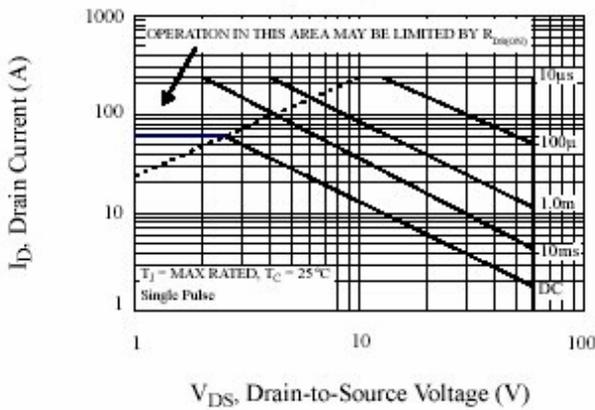


**Figure 12. Typical Threshold Voltage vs Junction Temperature**

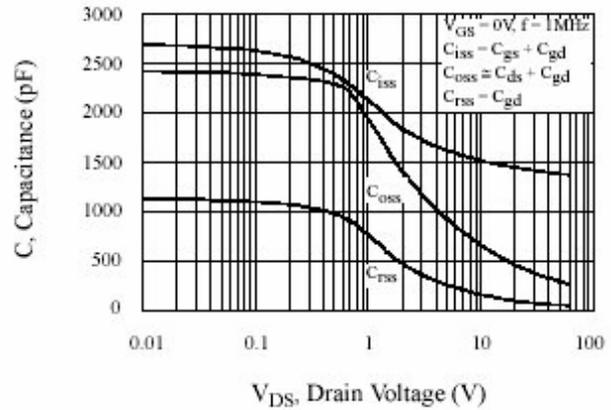


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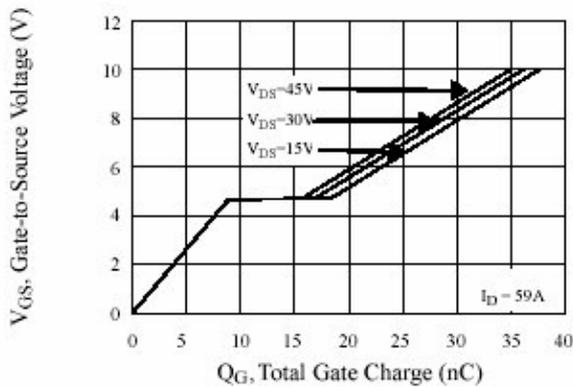
**Figure 13. Maximum Forward Bias Safe Operating Area**



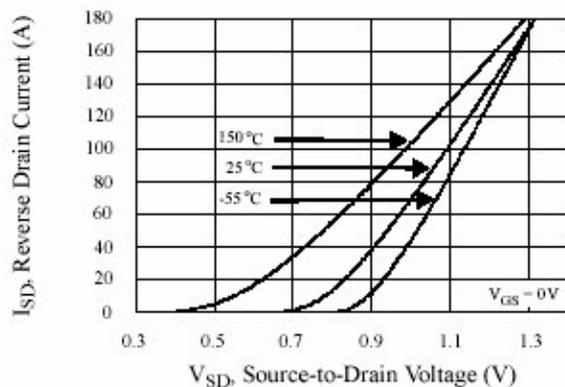
**Figure 14. Typical Capacitance vs Drain-to-Source Voltage**

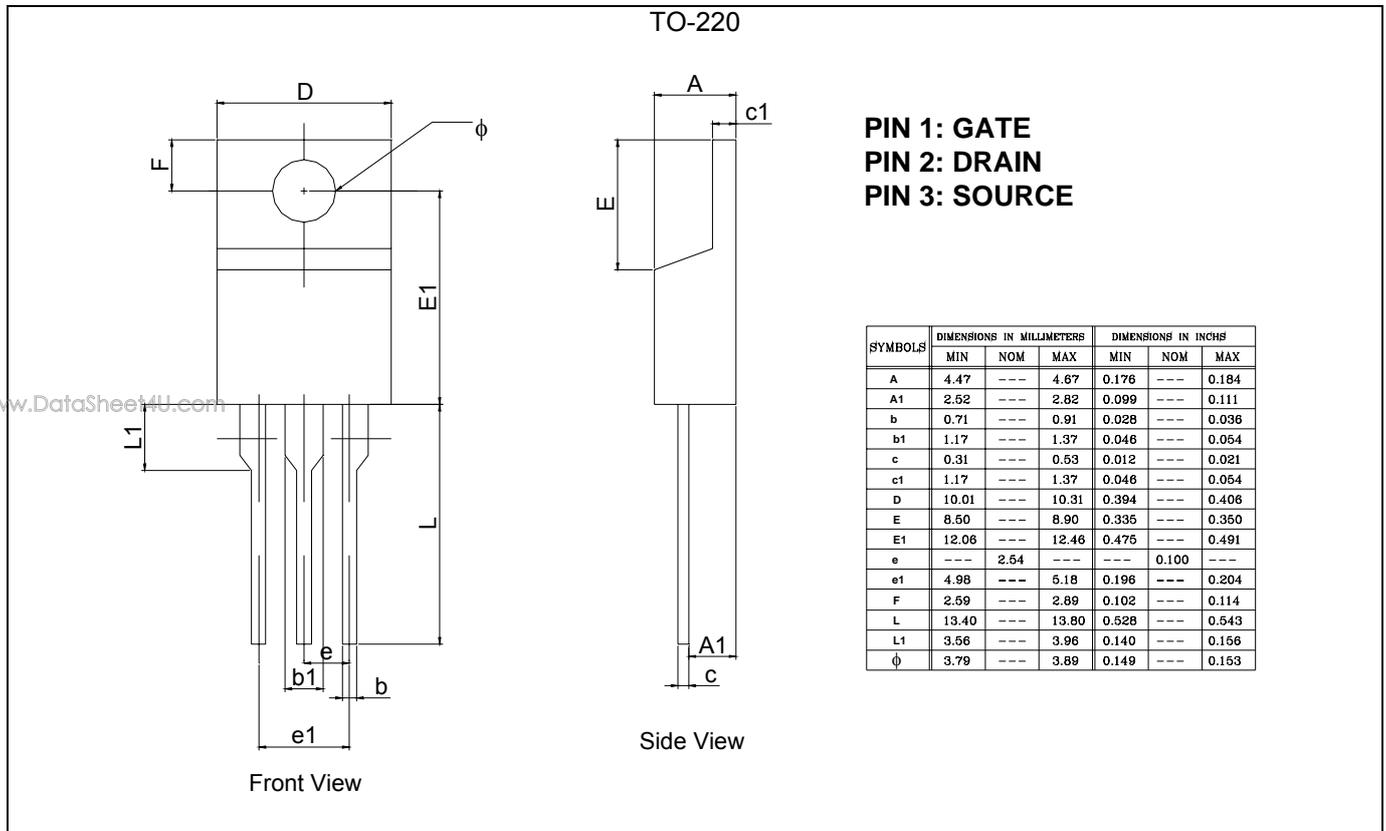


**Figure 15. Typical Gate Charge vs Gate-to-Source Voltage**



**Figure 16. Typical Body Diode Transfer Characteristics**



**PACKAGE DIMENSION**


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#### HsinChu Headquarter

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5F-1, No. 11, Park Avenue II,  
Science-Based Industrial Park,  
HsinChu City, Taiwan  
TEL: +886-3-567 9979  
FAX: +886-3-567 9909

#### Sales & Marketing

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11F, No. 306-3, SEC. 1, Ta Tung Road,  
Hsichih, Taipei Hsien 221, Taiwan  
TEL: +886-2-8692 1591  
FAX: +886-2-8692 1596

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